

Search Notes

Application/Control No.

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Hai C. Pham

Applicant(s)/Patent under
Reexamination

SUGIYAMA ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	224-225, 241, 244, 256, 258	5/22/2006	HP
156	273.3	5/22/2006	HP
369	93-94	5/22/2006	HP
	118,272.1		
	283, 286		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	5/22/2006	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner